

Uncertainty (%)	$d\sigma/dp_T$	$d\sigma/d \eta $	$d\sigma/dp_T^Z$	$d\sigma/dH_T$	$d\sigma/d\Delta\phi_{Zb}$
JER	0.3–1.7	0.1–0.6	0.2–2.6	0.4–1.9	0.1–2.2
JES	0.5–4.8	0.7–5.3	0.5–7.7	0.6–5.2	0.4–4.2
Unfolding (MC model)	0.0–19.2	0.2–2.2	0.0–18.1	0.0–10.2	0.0–9.2
Unfolding (MC statistics)	1.4–10.2	1.1–2.7	1.8–8.3	1.3–7.6	1.2–6.1
c, udsg background model	0.0–6.1	0.0–7.0	0.0–19.9	0.7–7.5	0.0–10.9
Electron (muon) efficiency	1.5 (2.0)	1.5 (2.0)	1.5 (2.0)	1.5 (2.0)	1.5 (2.0)
b tagging efficiency	3.0	3.0	3.0	3.0	3.0
Pileup	0.2–4.3	0.6–1.4	0.4–2.0	0.2–2.3	0.2–1.6
Background (systematic)	0.1–0.4	0.1–0.3	0.1–0.6	0.2–0.3	0.1–0.3
Background (statistical)	1.2–7.2	1.0–2.5	1.5–5.8	1.3–4.6	1.2–5.9
Integrated luminosity	2.6	2.6	2.6	2.6	2.6
Total syst. uncertainty (%)	5.5–21.7	5.2–10.6	5.6–22.8	8.4–13.8	6.0–13.3
Total stat. uncertainty (%)	2.6–8.8	3.0–5.4	2.9–8.6	3.1–6.0	3.1–7.0